

Monolithic General Purpose CMOS Analog Switches

FEATURES

- ± 15 Volt Input Range
- ON Resistance < 50 Ω
- Break-Before-Make Switching
- TTL and CMOS Compatible

BENEFITS

- Improved Signal Headroom
- Reduced Switching Errors
- No Shorting of Inputs
- Simple Interfacing

APPLICATIONS

- Audio Switching
- Sample and Hold Circuits

DESCRIPTION

The DG5040 family of solid state analog switches are recommended for general purpose applications in instrumentation, and process control. Built on the Siliconix PLUS 40 high voltage CMOS monolithic process, these devices provide ease-of-use and performance advantages to the system designer. Key performance features of the 5040 series are 1 μ s switching, low power supply requirements, and break-before-make switching which guarantees that an ON channel will be turned OFF before an OFF channel can turn ON. Each switch conducts equally in either direction, when ON, and blocks up to 30 volts peak-to-peak when OFF. OFF leakage

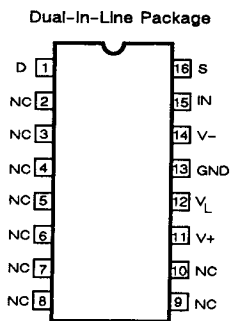
current is 1 nA maximum. A epitaxial layer prevents latch up.

There are six devices in this series, which are differentiated by the type of switch action as shown in the functional block diagrams. In all cases the switches are bidirectional and maintain almost constant ON resistance throughout their operating range.

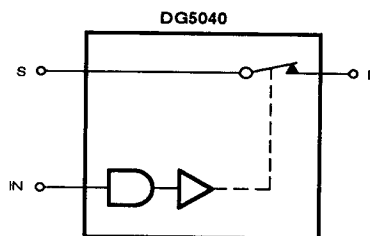
Package options include the 16-pin plastic and CerDIP. Temperature grades include commercial, C suffix (0 to 70°C), and military, A suffix (-55 to 125°C). For new designs, upgrade to the DG400-405 devices.

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PIN CONFIGURATION, FUNCTIONAL BLOCK DIAGRAM AND TRUTH TABLE



Top View
Order Numbers:
CerDIP: DG5040AK
 DG5040CK
Plastic: DG5040CJ



One SPST Switch per Package

Truth Table*

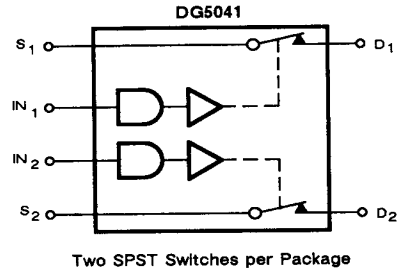
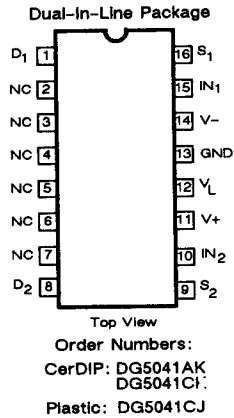
LOGIC	SWITCH
0	OFF
1	ON

Logic "0" ≤ 0.8 V

Logic "1" ≥ 2.0 V

*Switches Shown for Logic "1" Input.

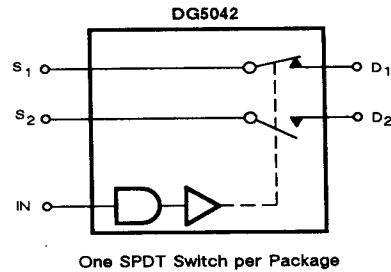
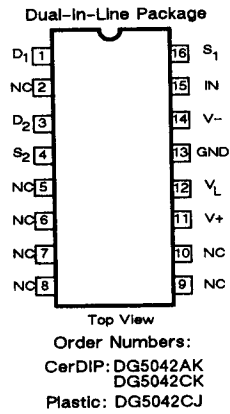
PIN CONFIGURATION, FUNCTIONAL BLOCK DIAGRAM AND TRUTH TABLE (Cont'd)



Truth Table*

LOGIC	SWITCH
0	OFF
1	ON

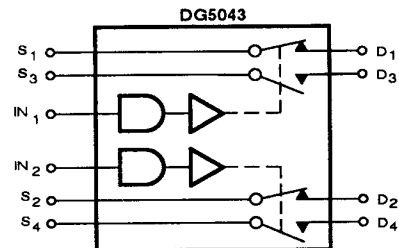
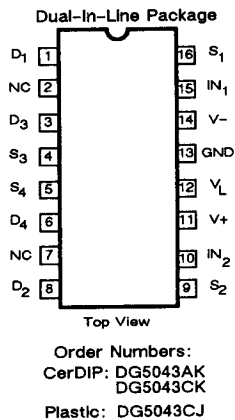
Logic "0" \approx 0.8 V
Logic "1" \approx 2.0 V



Truth Table*

LOGIC	SWITCH 1	SWITCH 2
0	OFF	ON
1	ON	OFF

Logic "0" \approx 0.8 V
Logic "1" \approx 2.0 V



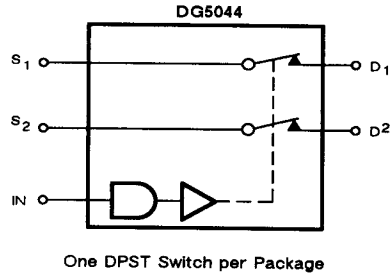
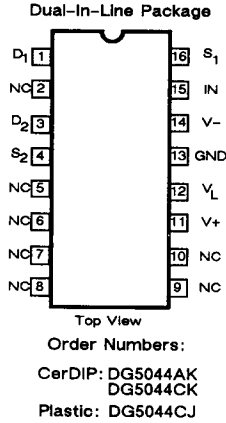
Truth Table*

LOGIC	SWITCH 1	SWITCH 2	SWITCH 3	SWITCH 4
0	OFF	ON	ON	OFF
1	ON	OFF	OFF	ON

Logic "0" \approx 0.8 V
Logic "1" \approx 2.0 V

*Switches Shown for Logic "1" Input

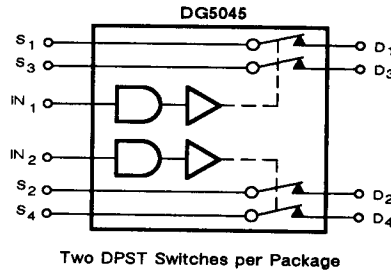
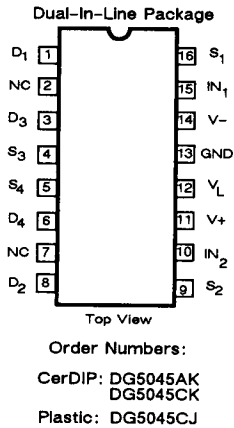
PIN CONFIGURATION, FUNCTIONAL BLOCK DIAGRAM AND TRUTH TABLE (Cont'd)



Truth Table*

LOGIC	SWITCH
0	OFF
1	ON

Logic "0" \approx 0.8 V
Logic "1" \approx 2.0 V



Truth Table*

LOGIC	SWITCH
0	OFF
1	ON

Logic "0" \approx 0.8 V
Logic "1" \approx 2.0 V

*Switches Shown for Logic "1" Input

ABSOLUTE MAXIMUM RATINGS

Voltages Referenced to V-

- V+ 44V
- VL (GND - 0.3 V) to 44 V
- GND 25V
- Digital Inputs^f VS, VD ... (V- minus 2 V) to (V+ plus 2 V)
or 30 mA, whichever occurs first
- Current (any terminal except S or D) 30 mA
- Continuous Current (S or D) 30 mA
- Peak Current (S or D)
- Pulsed 1 ms 10% duty cycle max 100 mA

Storage Temperature (A Suffix) -65 to 150°C
(C Suffix) -65 to 125°C

Operating Temperature (A Suffix) -55 to 125°C
(C Suffix) 0 to 70°C

Power Dissipation*
16-Pin Plastic DIP** 450 mW
16-Pin Ceramic DIP*** 900 mW

- * All leads welded or soldered to PC board.
- ** Derate 6 mW/°C above 75°C
- *** Derate 12 mW/°C above 75°C

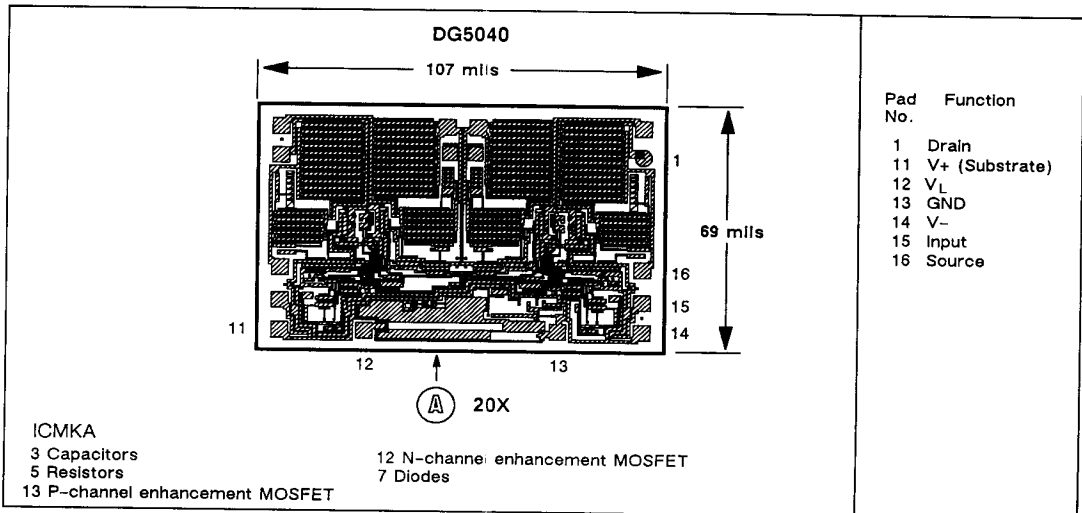
ELECTRICAL CHARACTERISTICS ^a									
PARAMETER	SYMBOL	Test Conditions Unless Otherwise Specified: V ₊ = 15 V V ₋ = -15 V V _L = 5 V GND = 0 V V _{IN} = 2.0 V, 0.8 V ^e	LIMITS						UNIT
			1=25°C 2=125,70°C 3=-55,0°C		A SUFFIX -55 to 125°C		C SUFFIX 0 to 70°C		
			TEMP	TYP ^d	MIN ^b	MAX ^b	MIN ^b	MAX ^b	
SWITCH									
Analog Signal Range ^c	V _{ANALOG}		1,2,3		-15	15	-15	15	V
Drain-Source ON Resistance	r _{DS(ON)}	I _S = -10 mA, V _D = ±10 V	1,3 2			50 75		50 75	Ω
Switch OFF Leakage Current	I _{S(OFF)}	V _D = -14 V, V _S = 14 V V _D = 14 V, V _S = -14 V	1 2		-1 -100	1 100	-1 -100	1 100	nA
	I _{D(OFF)}		1 2		-1 -100	1 100	-1 -100	1 100	
Channel ON Leakage Current	I _{D(ON)} + I _{S(ON)}	V _S = V _D = 14 V	1 2			2 200		2 200	nA
		V _S = V _D = -14 V	1 2		-2 -200		-2 -200		
INPUT									
Input Current with V _{IN} LOW	I _{IL}	V _{IN} under test = 0.8 V	1,2		-1.0	1.0	-1.0	1.0	μA
Input Current with V _{IN} HIGH	I _{IH}	V _{IN} under test = 2.0 V	1,2		-1.0	1.0	-1.0	1.0	
DYNAMIC									
Turn-ON Time	t _{ON}	V _S = ±10 V R _L = 1 kΩ, C _L = 35 pF See Figure 1A	1			1000		1200	ns
Turn-OFF Time	t _{OFF}		1			500		700	
Charge Injection ^c	Q	C _L = 10,000 pF V _{gen} = 0 V, R _{gen} = 0 Ω	1	30					pC
Off Isolation ^c		R _L = 75 Ω, C _L = 5 pF f = 1 MHz	1	75					dB
Crosstalk ^c (Channel-to-Channel)		R _L = 75 Ω, V _S = 2 Vp-p f = 1 MHz	1	89					
Source-OFF Capacitance ^c	C _{S(OFF)}	V _D = V _S = 0 V f = 1 MHz	1	15					pF
Drain-OFF Capacitance ^c	C _{D(OFF)}		1	17					
Channel ON Capacitance ^c	C _{D(ON)} + C _{S(ON)}		1	45					

ELECTRICAL CHARACTERISTICS ^a								
PARAMETER	SYMBOL	Test Conditions Unless Otherwise Specified: V ₊ = 15 V V ₋ = -15 V V _L = 5 V GND = 0 V V _{IN} = 2.0 V, 0.8 V ^e	LIMITS				UNIT	
			1=25°C		A SUFFIX			
			TEMP	TYP ^d	MIN ^b	MAX ^b		MIN ^b
SUPPLY								
Positive Supply Current	I ₊	V _{IN} = 0.0 or 2.4 V	1, 2		300		300	μA
Negative Supply Current	I ₋		1, 2		-300		-300	
Logic Supply Current	I _L		1, 2		300		300	
Ground Current	I _{GND}		1, 2		-300		-300	

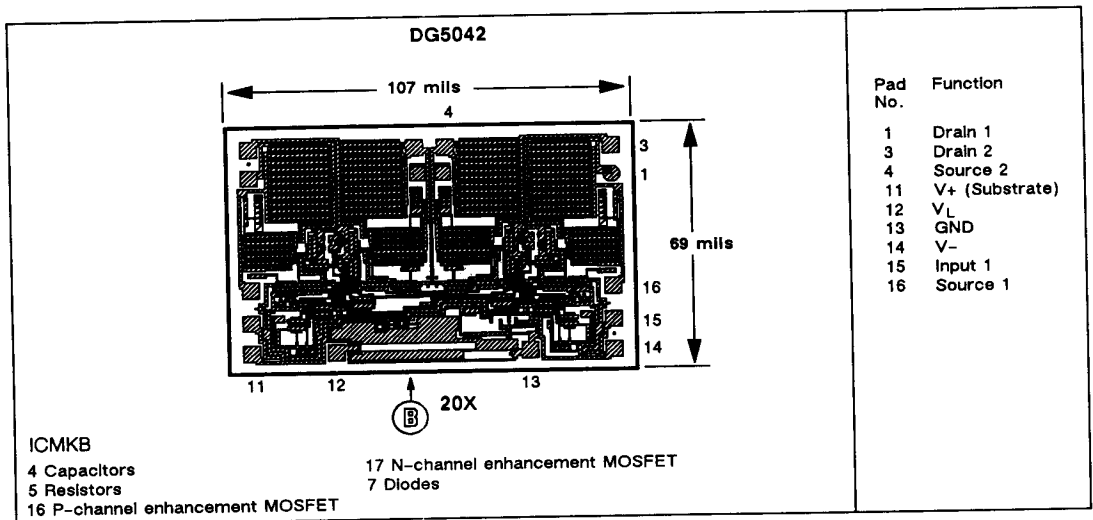
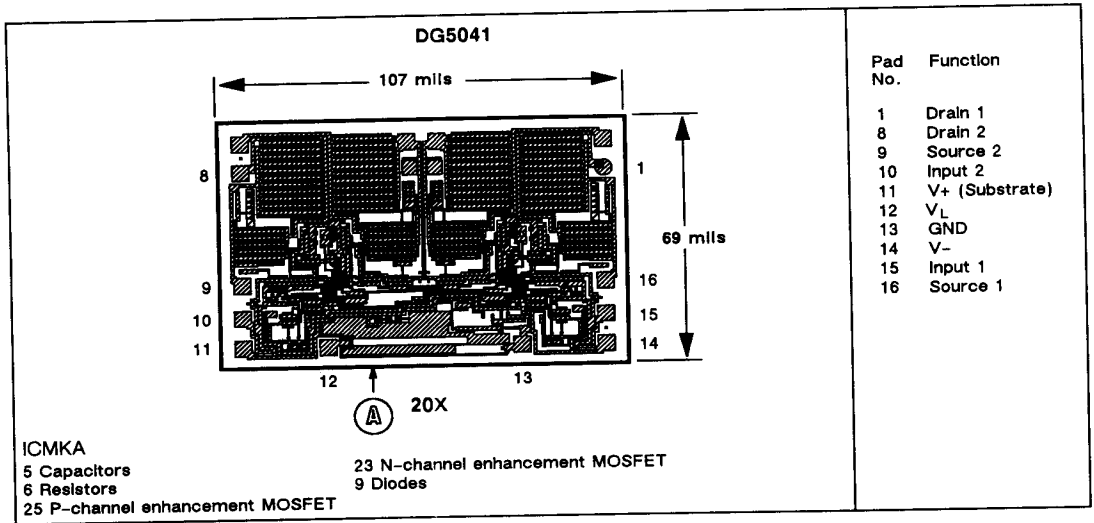
NOTES:

- a. Refer to PROCESS OPTION FLOWCHART for additional information.
- b. The algebraic convention whereby the most negative value is a minimum and the most positive a maximum, is used in this data sheet.
- c. Guaranteed by design, not subject to production test.
- d. Typical values are for DESIGN AID ONLY, not guaranteed nor subject to production testing.
- e. V_{IN} = Input voltage to perform proper function.
- f. Signals on S_X, D_X or I_{NX} exceeding V₊ or V₋ will be clamped by internal diodes. Limit forward diode current to 30 mA.

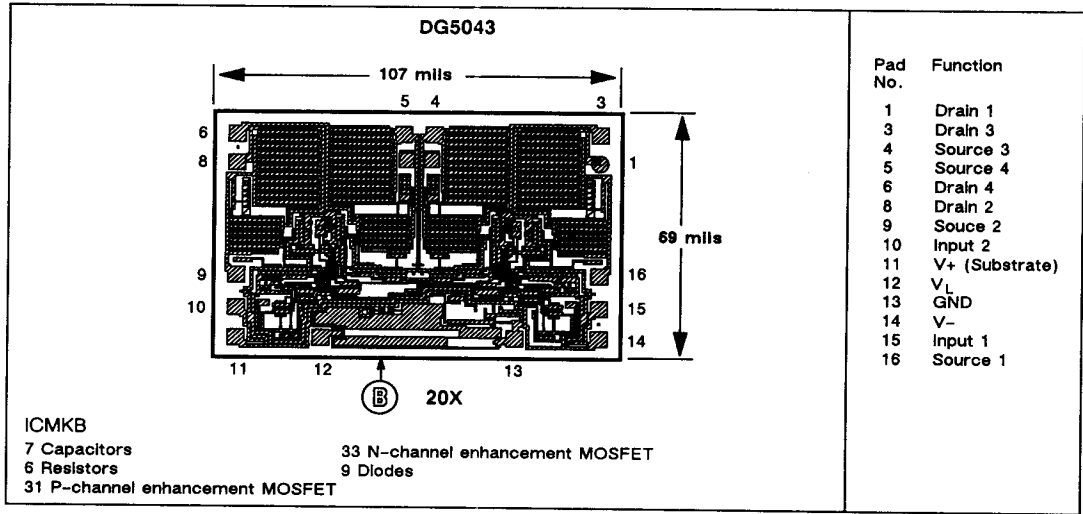
DIE TOPOGRAPHY



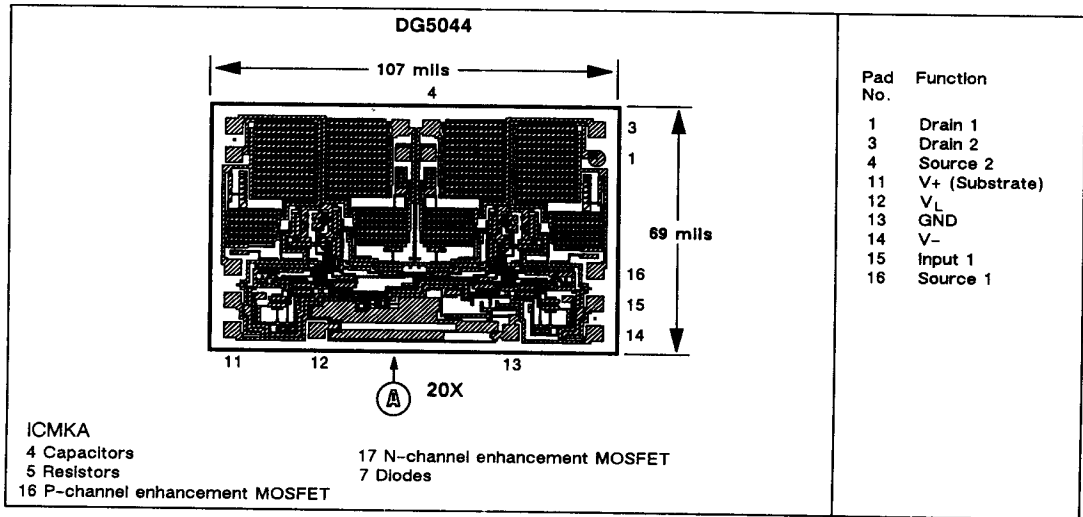
DIE TOPOGRAPHY (Cont'd)



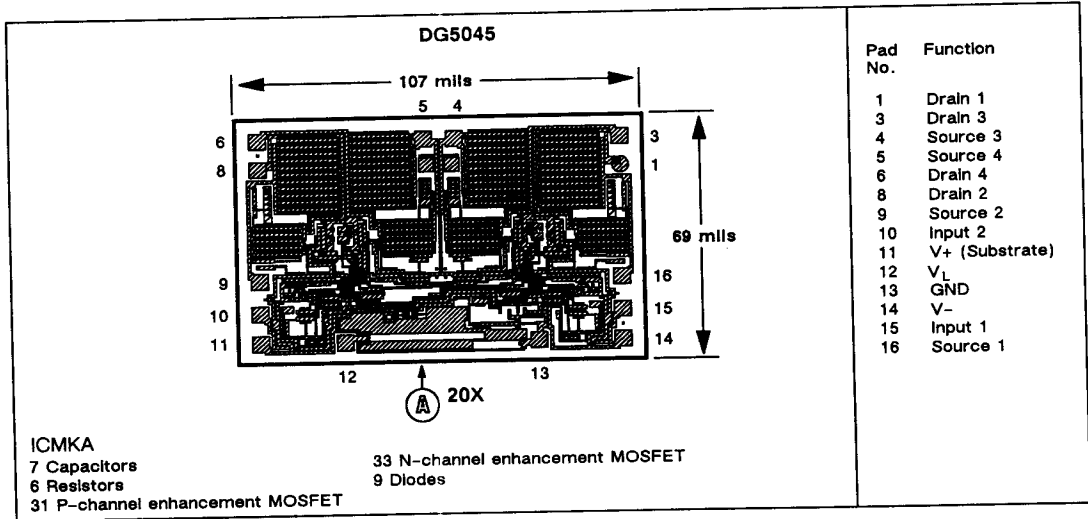
DIE TOPOGRAPHY (Cont'd)



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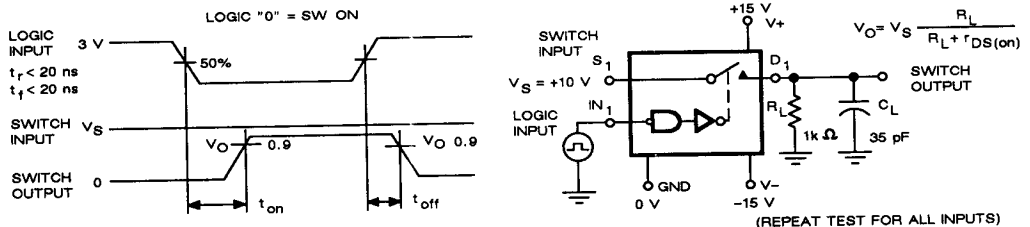


DIE TOPOGRAPHY (Cont'd)

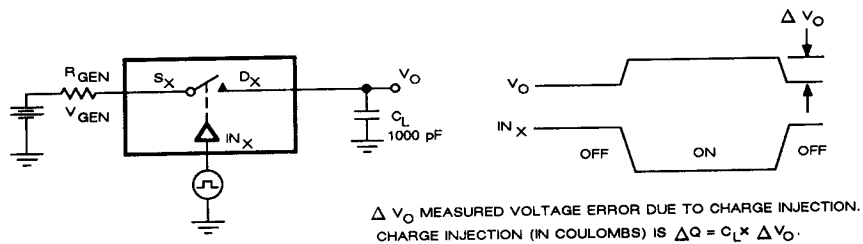


SWITCHING TIME TEST CIRCUIT

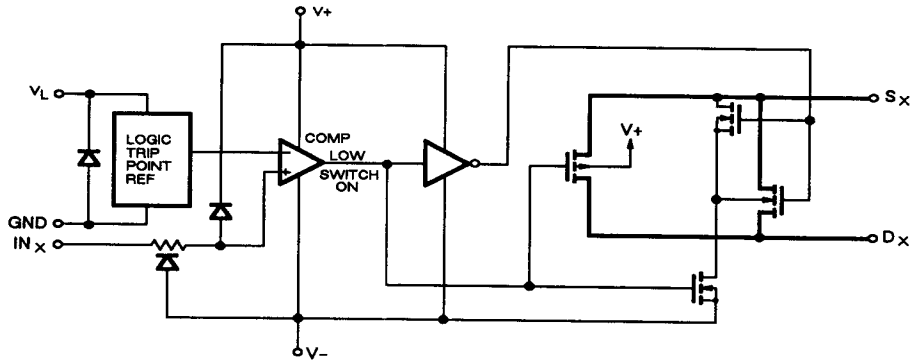
Switch output waveform shown for $V_S = \text{constant}$ with logic input waveform as shown. Note that V_S may be + or - as per switching time test circuit. V_O is the steady state output with switch ON. Feedthrough via gate capacitance may result in spikes at leading and trailing edge of output waveform.



CHARGE INJECTION TEST CIRCUIT



SCHEMATIC DIAGRAM (Typical Channel)



Low-Power – High-Speed CMOS Analog Switches

FEATURES

- ± 15 Volt Input Range
- ON Resistance < 50 Ω
- Very Fast Switching Action
($t_{ON} < 100$ ns)
($t_{OFF} < 75$ ns)
- Ultra Low Power Requirements
($I_S < 1 \mu A$)
- TTL and CMOS Compatible

BENEFITS

- Improved Signal Headroom
- Low Signal Errors
- Break-Before-Make Switching Action
- Reduced Power Consumption
- Simple Interfacing

APPLICATIONS

- Audio Switching
- Precision Switching
- High-Speed Switching
- Battery-Operated Systems

DESCRIPTION

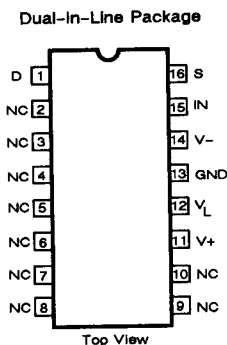
The DG5140 family of solid state analog switches is built on the Siliconix proprietary high voltage silicon gate process to achieve high voltage rating and superior switch time ON/OFF performance. Key performance features of the DG5140 series are break-before-make switching action to guarantee that an ON channel will be turned OFF before the OFF channel can turn ON, ultra-low power supply requirements, and TTL and CMOS compatibility. Each switch conducts equally well in both directions when ON and blocks up to 30 Volts peak-to-peak when OFF. With switch OFF leakage less than 100 pA and maximum power supply current of 1 μA

(A Suffix), these switches are ideal for battery powered industrial and military applications. An epitaxial layer prevents latchup.

There are six devices in this series, which are differentiated by the type of switch action as shown in the functional block diagrams. In all cases the switches are bidirectional and maintain almost constant ON resistance throughout their operating range.

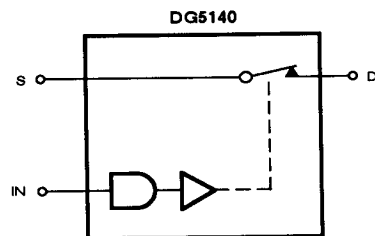
Package options include the 16-pin plastic and ceramic DIP. Temperature grades include commercial, C suffix (0 to 70°C), and military, A suffix (-55 to 125°C).

PIN CONFIGURATION



Order Numbers:
CerDIP: DG5140AK, DG5140AK/883,
DG5140CK
Plastic: DG5140CJ

FUNCTIONAL BLOCK DIAGRAM



One SPST Switch per Package

Truth Table *

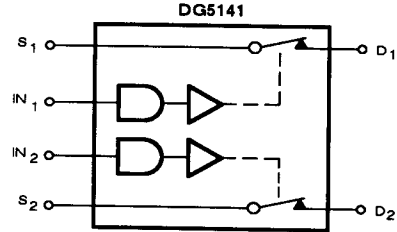
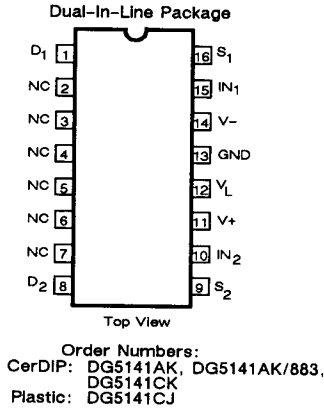
LOGIC	SWITCH
0	OFF
1	ON

Logic "0" \leq 0.8 V
Logic "1" \geq 2.4 V

* Switches Shown for Logic "1" Input

PIN CONFIGURATION (Cont'd)

FUNCTIONAL BLOCK DIAGRAM (Cont'd)

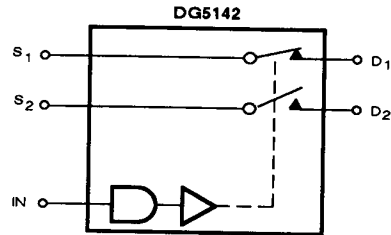
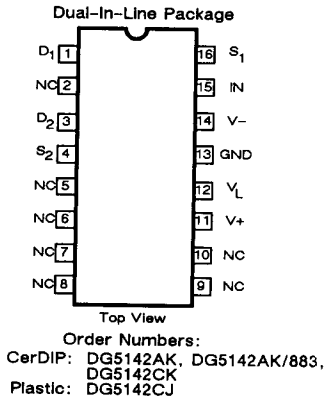


Two SPST Switches per Package

Truth Table *

LOGIC	SWITCH
0	OFF
1	ON

Logic "0" \leq 0.8 V
Logic "1" \geq 2.4 V

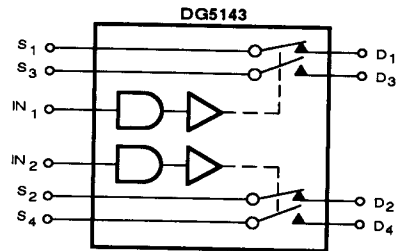
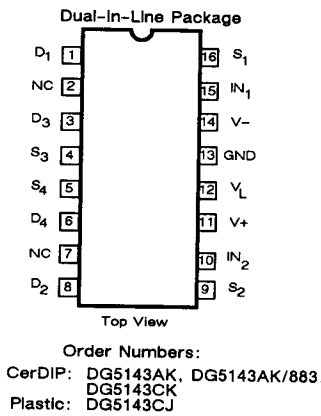


One SPDT Switch per Package

Truth Table *

LOGIC	SWITCH 1	SWITCH 2
0	OFF	ON
1	ON	OFF

Logic "0" \leq 0.8 V
Logic "1" \geq 2.4 V



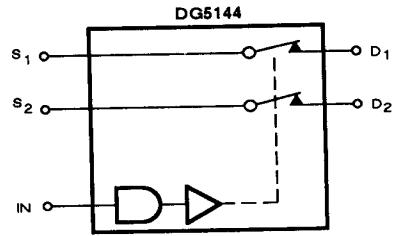
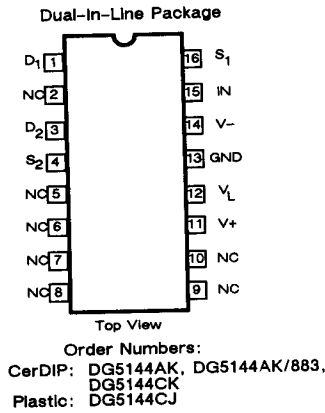
Two SPDT Switches per Package

Truth Table *

LOGIC	SWITCH 1 SWITCH 2	SWITCH 3 SWITCH 4
0	OFF	ON
1	ON	OFF

Logic "0" \leq 0.8 V
Logic "1" \geq 2.4 V

* Switches Shown for Logic "1" Input

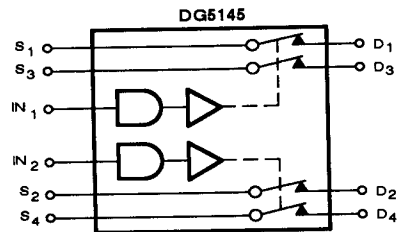
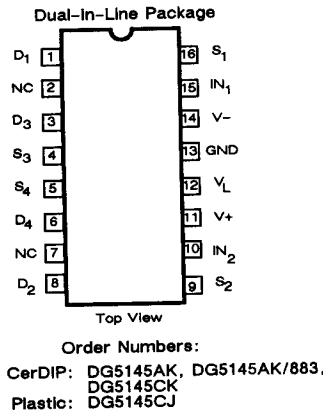


One DPST Switch per Package

Truth Table *

LOGIC	SWITCH
0	OFF
1	ON

Logic "0" \leq 0.8 V
 Logic "1" \geq 2.4 V



Two DPST Switches per Package

Truth Table *

LOGIC	SWITCH
0	OFF
1	ON

Logic "0" \leq 0.8 V
 Logic "1" \geq 2.4 V

* Switches Shown for Logic "1" Input

ABSOLUTE MAXIMUM RATINGS

(V+) - (V-)	< 36 V
(V+) - (VD)	< 30 V
(VD) - (V-)	< 30 V
(VD) - (VS)	< \pm 22 V
(VL) - (V-)	< 33 V
(VL) - (VIN)	< 30 V
VL	< 20 V
VIN	< 20 V
Continuous Current, Any Terminal	30 mA

Peak Current, S or D (Pulsed at 1 ms, 10% duty cycle max)	100 mA
Storage Temperature (A Suffix)	-65 to 150°C
(C Suffix)	-65 to 125°C
Operating Temperature (A Suffix)	-55 to 125°C
(C Suffix)	0 to 70°C
Power Dissipation (Package) *	
16-Pin Plastic DIP**	450 mW
16-Pin CerDIP***	900 mW

* All leads welded or soldered to PC board.

** Derate 6 mW/°C above 75°C.

*** Derate 12 mW/°C above 75°C.

ELECTRICAL CHARACTERISTICS ^a

PARAMETER	SYMBOL	Test Conditions Unless Otherwise Specified: V ₊ = 15 V V ₋ = -15 V V _L = 5 V GND = 0 V V _{IN} = 2.4 V, 0.8 V ^e	LIMITS						UNIT
			1=25°C		A SUFFIX -55 to 125°C		C SUFFIX 0 to 70°C		
			TEMP	TYP ^d	MIN ^b	MAX ^b	MIN ^b	MAX ^b	
SWITCH									
Analog Signal Range ^c	V _{ANALOG}		1,2,3		-14	14	-14	14	V
Drain-Source ON Resistance	r _{DS(ON)}	V ₊ = 15 V, V ₋ = -15 V I _S = -10 mA, V _D = ±10 V	1 2, 3			50 75		75 100	Ω
Switch OFF Leakage Current	I _{S(OFF)}	V _D = -10 V, V _S = 10 V V _D = 10 V, V _S = -10 V	1 2			0.5 20		5 20	nA
	I _{D(OFF)}		1 2			0.5 20		5 20	
Channel ON Leakage Current	I _{D(ON)} + I _{S(ON)}	V _S = V _D = -10 to 10 V	1 2			1 40		2 40	nA
INPUT									
Input Current with V _{IN} LOW	I _{IL}	V _{IN} under test = 0.8 V All Other = 2.4 V	1,2			1		1	μA
Input Current with V _{IN} HIGH	I _{IH}	V _{IN} under test = 2.4 V All Other = 0.8 V	1,2			1		1	μA
DYNAMIC									
Turn-ON Time	t _{ON}	R _L = 300Ω, C _L = 35 pF See Figure 1 DG5140-DG5145	1			150		175	ns
Turn-OFF Time	t _{OFF}		1			125		150	
Switch ON Time ^c	t _{ON}	DG5140 DG5141	Figure 2	1		100		150	
			Figure 3	1		150		175	
		DG5142 DG5143	Figure 2 and 4	1		175		250	
			Figure 5	1		200		300	
Switch OFF Time ^c	t _{OFF}	DG5140 DG5141	Figure 2	1		75		125	
			Figure 3	1		125		150	
		DG5142 DG5143 DG5144 DG5145	Figures 2,3,4 and 5	1		125		150	
				1		125		150	

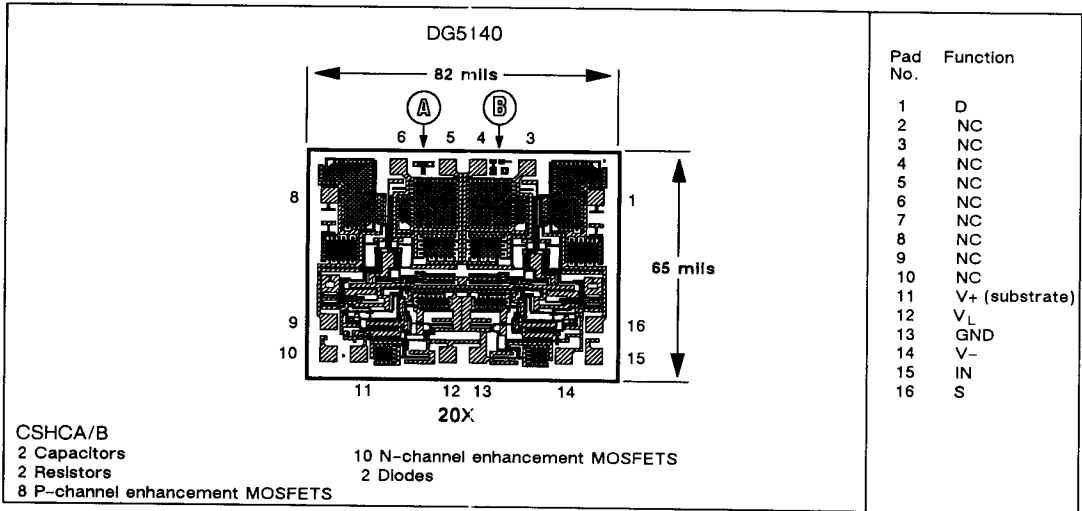
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ELECTRICAL CHARACTERISTICS ^a									
PARAMETER	SYMBOL	Test Conditions Unless Otherwise Specified: V ₊ = 15 V V ₋ = -15 V V _L = 5 V GND = 0 V V _{IN} = 2.4 V, 0.8 V ^e	LIMITS						UNIT
			1=25°C		A SUFFIX -55 to 125°C		C SUFFIX 0 to 70°C		
			TEMP	TYP ^d	MIN ^b	MAX ^b	MIN ^b	MAX ^b	
Break-Before-Make Time	t _{ON} - t _{OFF}	See Figure 2	1		10		5		ns
			1		10		5		
Charge Injection ^c	Q	C _L = 10,000 pF V _{gen} = 0 V, R _{gen} = 0 Ω	1		100		150		pC
Off Isolation ^c		R _L = 100 Ω, C _L ≤ 5 pF f = 1 MHz	1		-54		-50		dB
Crosstalk ^c (Channel-to-Channel)		Any Other Channel Switches R _L = 100 Ω, C _L ≤ 5 pF f = 1 MHz	1		-54		-50		
SUPPLY									
Positive Supply Current	I ₊	V _{IN} = 0 V or 5 V Switch Duty Cycle < 10%	1			1		10	μA
Negative Supply Current	I ₋		1		-1		-10		
Logic Supply Current	I _L		1			1		10	
Ground Current	I _{GND}		1		-1		-10		

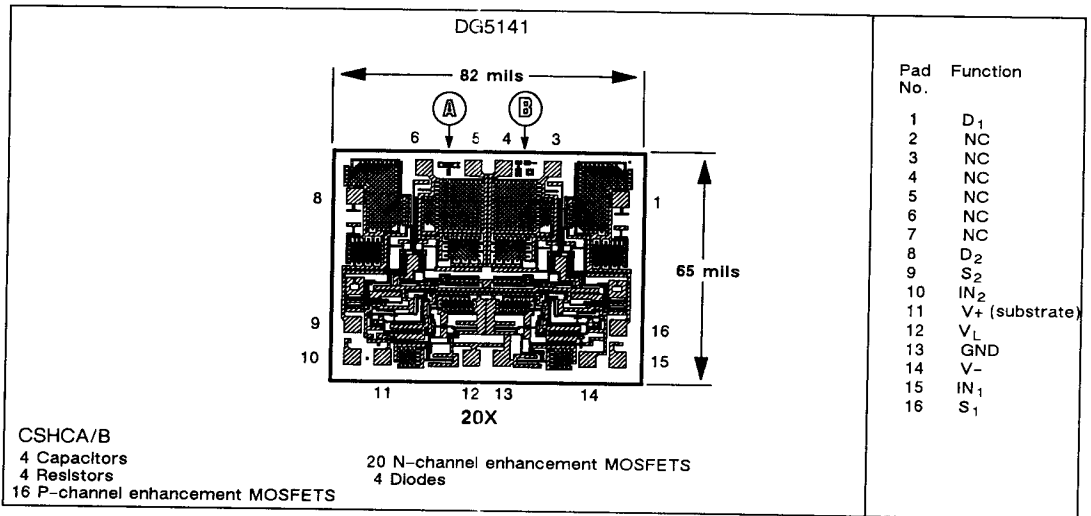
NOTES:

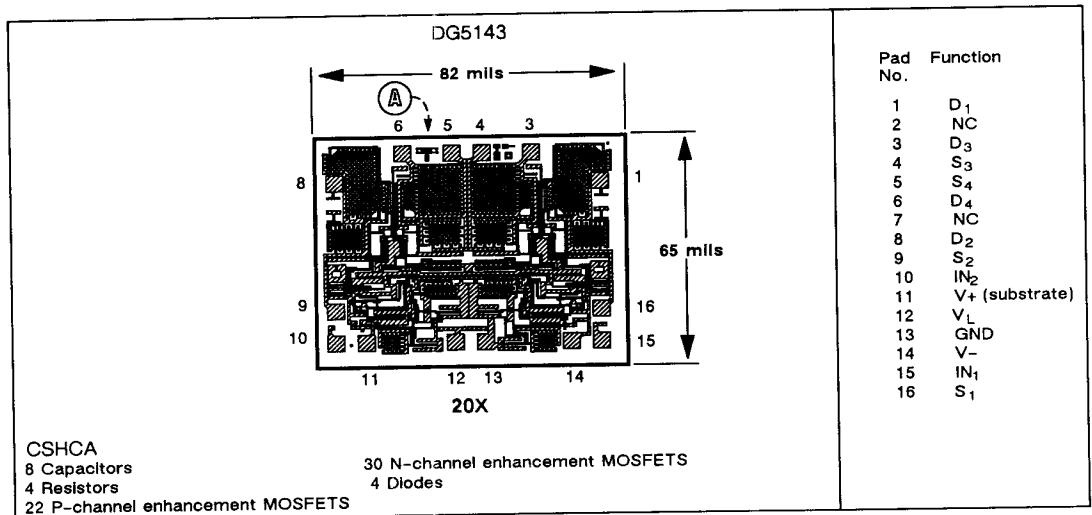
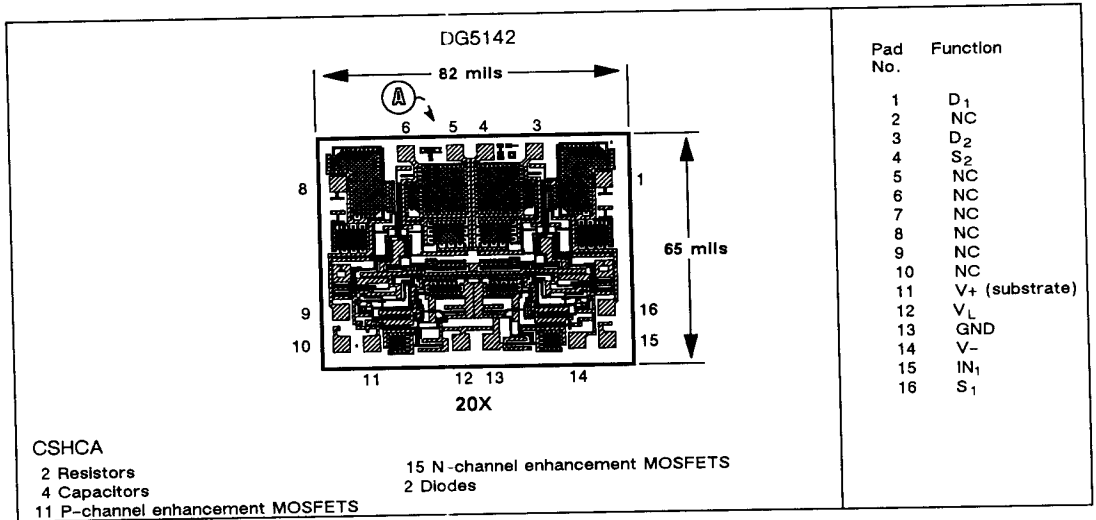
- a. Refer to PROCESS OPTION FLOWCHART for additional information.
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- d. Typical values are for DESIGN AID ONLY, not guaranteed nor subject to production testing.
- e. V_{IN} = Input voltage to perform proper function.
- f. Signals on S_X, D_X or IN_X exceeding V₊ or V₋ will be clamped by internal diodes. Limit forward diode current to 30 mA.

DIE TOPOGRAPHY

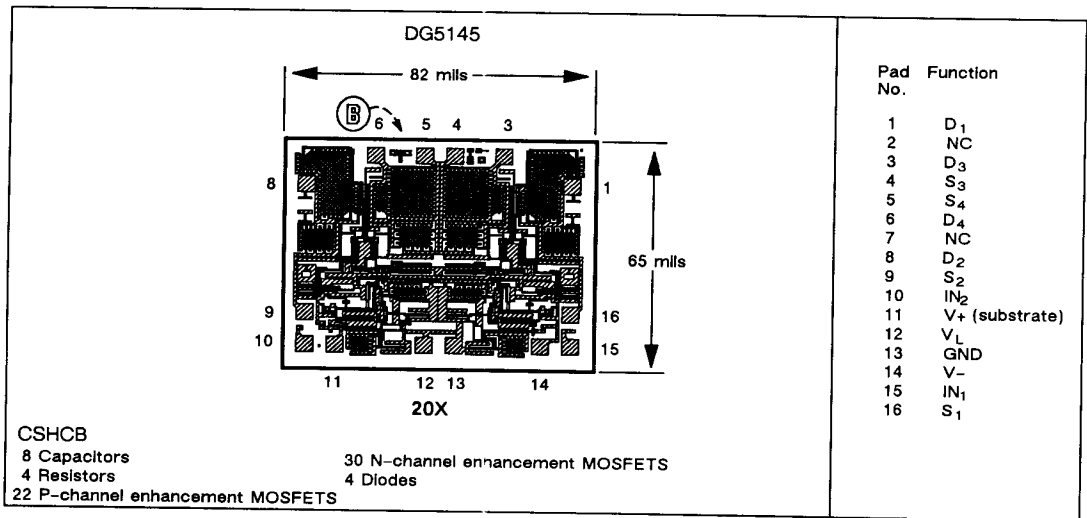
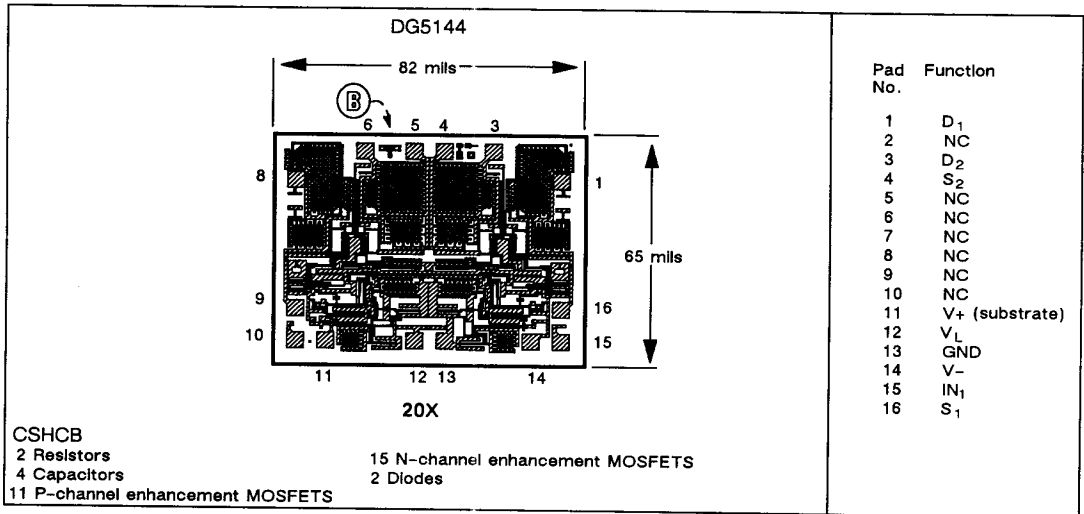


5





DIE TOPOGRAPHY (Cont'd)



SWITCHING TIME TEST CIRCUITS

Switch output waveform shown for $V_S = \text{constant}$ with logic input waveform as shown. Note that V_S may be + or - as per switching time test circuit. V_O is the steady state output with switch ON. Feedthrough via gate capacitance may result in spikes at leading and trailing edge of output waveform.

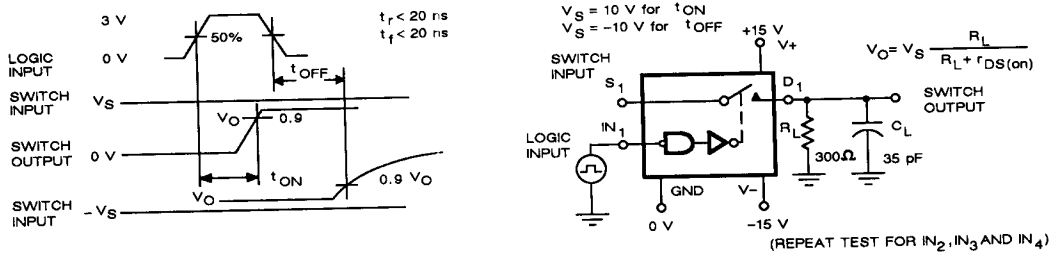


Figure 1.

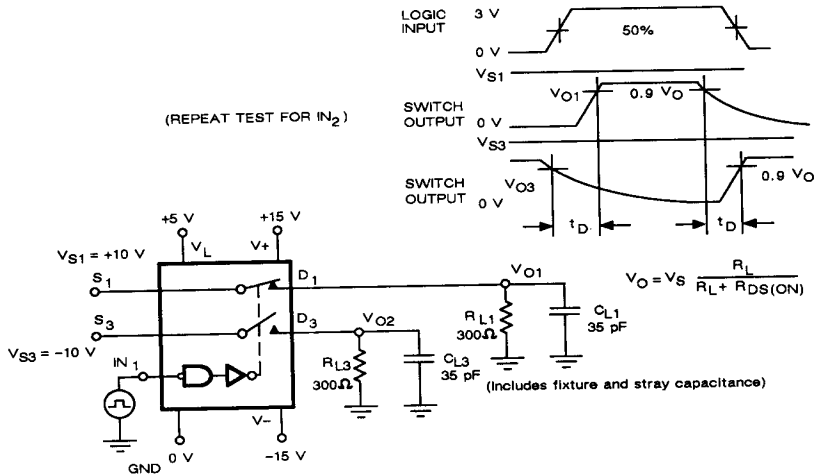


Figure 2.